Search Notes

_	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/737,281	WEI ET AL.
	Examiner	Art Unit
	Michael D. Pham	2167

	SEAR	CHED	
Class	Subclass	Date	Examiner
707	200	11/16/2006	MP
			,

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated inventor search	11/16/2006	MP		
Updated assignee search	11/16/2006	MP		
updated east search	11/16/2006	MP		
	,			